

Application/Control No. 10/780,939	Applicant(s)/Patent under Reexamination LEE, CHANG-KYU	
James D. Ewart	2683	

SEARCHED			
Class	Subclass	Date	Examiner
455	9	10/13/2005	JDE
	13.3		
	26.1		
	63.4		
	67.11		
	68		
	82		
	115.1		
	115.4		
	121		
	123		
	129		
	193.1		
	226.1		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES  STRATEGY	′)
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Search Notes (continued)

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,939	LEE, CHANG-KYU	
Examiner	Art Unit	
James D. Ewart	2683	

SEARCHED			
Class	Subclass	Date	Examiner
455	423	10/13/2005	JDE
	562.1		
	550.1		
	575.7		
343	703		
	711		
	751		
	893		
	894		
	876		
342	173		
	423		
	444		

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